# STRUCTURAL STUDIES OF FERROELECTRIC BATIO<sub>3</sub> NANO PARTICLES AND VACUUM EVAPORATED BATIO<sub>3</sub> NANO SCALE THIN FILMS

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# ABSTRACT

Barium titanate (BaTiO<sub>3</sub>) nanoparticles were prepared by wet chemical method using commercially available materials barium chloride, titanium dioxide and oxalic acid. Nano scale thin films of different thickness were coated on pre - cleaned glass substrate by using vacuum evaporation technique under a vacuum of  $2x10^{-5}$  Torr. The X - ray analysis showed that the particles have tetragonal structure. The deposited films of a lower thickness were found to be amorphous in nature, whereas the crystallinity increases with increase of thickness. The estimated value of grain size (D), strain and dislocation density ( $\delta$ ) were also reported in this paper.

#### Key words: BaTiO<sub>3</sub>, Thermal Evaporation, XRD

## **1. INTRODUCTION**

The discovery of ferroelectric barium titanate (BaTiO<sub>3</sub>) opens the present era of ceramic dielectric materials. BaTiO<sub>3</sub> having the perovskite structure with tetragonal symmetry at room temperature, possesses a relatively large dielectric constant ( $\epsilon$ ') and electro optic coefficient. Now-a-days BaTiO<sub>3</sub> has basic capacitor material become the in semiconductor technology. BaTiO<sub>3</sub> ceramics have a strong piezoelectric effect. These ceramics find wide applications in devices such as microphones, ultrasonic and underwater transducers, sensors and actuators, electro - optic device, multilayer capacitors and spark generators. BaTiO<sub>3</sub> is one of the  $ABO_3$  type (A = mono or divalent, B = tri-hexavalent ions) ceramic materials which have been examined in search of ferroelectric applications. Due to the desirable properties and applications, over the last few decades, synthesis of BaTiO<sub>3</sub> nanopowder and thin film has attracted great attention. Various chemical methods could be employed for the production of these fine particles like sol-gel techniques (Tangwiwat and Milne, 1988), coprecipitation, alkoxide hydrolysis (Kirby et al., 1988), metal-organic processing (Shaikh and Vest, 1986), hydrothermal treatment (Boulos et al., 2005) and mechanochemical synthesis (Stojanovic et al., 2005). Wet chemical method is a promising technique that offers relative low cost, uniform size, homogenous powder and high purity of the ceramics. In addition to that different techniques have also been applied to prepare thin film of barium titanate such as r.f.- sputtering (Bhattacharya et al., 1993), pulsed laser ablation (Yoon et al., 1995) and

metal-organic chemical vapour deposition (Tahan *et al.*, 1996).

Dent et al., have successfully optimized high velocity oxy-fuel (HVOF) spraving for the deposition of barium titanate as dense thick dielectric layer (25-150  $\mu$ m) and compared the dielectric constant (k) values of these deposits with those (k) values of BaTiO<sub>3</sub> layers produced by plasma spraying. The maximum dielectric constant values achieved by HVOF method of deposition are in the range 70-115. Plasma spraying of these materials has produced layers with k values close to 200. However, considerable success has been achieved for both process, some of the problems inherent in each type of deposition are still to be overcome. Despite several techniques have been explored to deposit thin film of BaTiO<sub>3</sub>, less attention has been devoted to thermal evaporation. In this paper, we have reported about the preparation of nanoscale BaTiO<sub>3</sub> thin films by thermal evaporation technique from BaTiO<sub>3</sub> nanoparticles synthesised by wet chemical method. Structure parameters of BaTiO<sub>3</sub> nanopartilces and vacuum evaporated nano scale thin films have also been reported.

#### 2. MATERIALS AND METHODS

#### 2.1. Synthesis of BaTiO<sub>3</sub> nanoparticles

BaTiO<sub>3</sub> nanoparticles were synthesized using wet chemical method. The starting materials used were barium chloride (BaCl<sub>2</sub>.2H<sub>2</sub>O), titanium dioxide (TiO<sub>2</sub>) powder and oxalic acid. A solution of barium chloride, titanium dioxide and oxalic acid having mole ratio1: 1: 1 was stirred and evaporated at 80°C till a clear, viscous resin was obtained and then dried at 100° C for 20 hours. The precursor formed was heated at 1000° C for 2 hours to form  $BaTiO_3$  nanoparticles.

## 2.2. BaTiO<sub>3</sub> nanoscale thin film preparation

Nano scale thin films of  $BaTiO_3$  were prepared by thermal evaporation of  $BaTiO_3$ nanoparticles evaporated onto pre-cleaned glass substrate under a vacuum of  $2x \ 10^{-5}$  torr, using a Hind High vacuum coating unit. The growth rate and thickness were measured during growth process by using a quartz crystal oscillator thickness monitor attached inside the vacuum evaporation chamber. The growth rate was adjusted to be as low as 1 Å/sec to avoid the differential evaporation of elements of the alloy.

# 2.3. Structural studies of $BaTiO_3$ nanoparticles and $BaTiO_3$ nanoscale thin films

The XRD patterns of the BaTiO<sub>3</sub> nanoparticles and their nanoscale thin films were obtained from X-ray powder diffraction with CuK $\alpha$  radiation ( $\lambda$  = 1.5418 Å).

## **3. RESULTS AND DISCUSSION**

## 3.1. X – Ray Diffraction Analysis

Fig.1 shows the X – ray diffraction pattern of the BaTiO<sub>3</sub> nanoparticles. The spectrum obtained exhibits a tetragonal polycrystalline structure with the preferred orientation along (101), (111), (002), (112), (003) and (113) and the value of interplanar spacing d were evaluated and compared with the standard JCPDS values of BaTiO<sub>3</sub> (Pattern: 00 - 003 - 0725) and are found to be in good agreement with the standard data [Hu et al.,].

The grain size is calculated from the full with half – maximum (FWHM) of the XRD peaks by using Scherrer formula

$$D = 0.94\lambda/\beta \cos\theta \qquad (1)$$

Where k is the wavelength of the X-rays used,  $2\theta$  is the angle between the incident and scattered X-rays, and  $\beta$  is the full width at half maximum. The strain ( $\epsilon$ ) was calculated from the formula

$$\varepsilon = \beta \cos\theta / 4 \tag{2}$$

The dislocation density ( $\delta$ ) is defined as the length of dislocation lines per unit volume of the crystal and is given by

$$\delta = 1/D^2 \tag{3}$$

Table.1 shows the calculated interplanar spacing (d), grain size (D), strain ( $\epsilon$ ) and dislocation density ( $\delta$ ) and the standard'd' values of

corresponding predominant peaks. The calculated 'd' values are found to be in agreement with the standard values. The average grain size (D), strain ( $\epsilon$ ) and dislocation density ( $\delta$ ) were found to be 26 nm, 1.40x10<sup>-3</sup> lin<sup>-2</sup>m<sup>-4</sup> and 1.58x10<sup>15</sup>lin/m<sup>2</sup>.





The X – ray diffraction pattern of the BaTiO<sub>3</sub> nano scale thin films of different thickness are shown in figure 2. It reveals that the films of lower thickness (80 nm) appear to be amorphous in nature without well-defined peaks, whereas the films of higher thickness are polycrystalline in nature. It is observed from diffactogram that the crystallites are preferentially oriented along (002) plane of the tetragonal structure. The intensity of the predominant peaks increases with increase in film thickness, indicating the high degree of preferential orientation towards these directions (12). This means that, at the initial state of film formation, i.e.; during the atomistic condensation of the film formation, the deposited atoms are at random orientations. As the film thickness increases, the polycrystalline grains begin to orient along their direction which is evident from the diffractograms of thickness 150 nm and 200 nm. The lattice parameter values determined for the peaks in the diffractograms coincide fairly well with the standard JCPDS data (pattern: 00 - 003 - 0725).





Table. 2 show a comparative look of the grain size, strain and dislocation density of the  $BaTiO_3$  films of different thickness. It is observed that the grain size increases with film thickness and attained a value of 23 nm for 200 nm thickness film. Due to the increase in grain size with film thickness, the

defect in the lattice are decreased, which is turn reduce the internal microstrain and dislocation density or the columnar grain growth is increased. The strain and dislocation density decreases with increase of thickness, which may be due to increase in crystallinity.

Table 1. Structural parameters of BaTiO<sub>3</sub> nano particle.

20	Standard JCPDS d- values (A <sup>0</sup> )	hkl	Calculated d- values(Aº)	D(nm)	ε x10 <sup>-3</sup> lin <sup>-2</sup> m <sup>-4</sup>	δx10 <sup>15</sup> lin/m <sup>2</sup>
28.80	2.83	101	2.94	29	1.18	1.18
36.08	2.31	111	2.39	24	1.46	1.73
41.19	1.8	102	1.88	23	1.62	1.89
54.28	1.64	112	1.73	25	1.38	1.0
68.91	1.34	003	1.36	25	1.52	1.73
80.88	1.21	113	1.18	27	1.25	1.37

Table 2. Structural parameter of BaTiO<sub>3</sub> nano scale thin films

Thickness (nm)	20	hkl	D(nm)	ε x10 <sup>-3</sup> lin <sup>-</sup>	δx10 <sup>15</sup> lin/m <sup>2</sup>
150	30.50	101	21.69	1.59	2.12
	35.19	111	21.06	1.64	2.25
	43.79	002	12.06	2.75	6.29
200	31.13	101	24.54	1.41	1.66
	35.65	111	22.73	1.52	1.93
	44.24	002	20.43	1.69	2.39

## 4. CONCLUSION

Nanoparticle of  $BaTiO_3$  were successfully synthesised by low cost wet chemical method using commercially available chemicals such as oxalic acid,  $TiO_2$  and  $BaCl_2$ . Thin films of few hundred nanometer thickness were prepared on well cleaned glass plate for the first time using thermal evaporation method. X-ray analysis showed that the nanoparticles have tetragonal nature and the deposited films at lower thickness have amorphous structure, whereas film of higher thicknesses showed increase in crystallinity. The crystallinity increases with increase of film thickness where as strain and dislocation density decreases with increase of film thickness. The improved crystallinity with temperature and thickness indicated the feasibility of utilising them for sensor applications.

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